

10/582665

AP3 Rec'd PCT/PTO 13 JUN 2006

Docket No.: NIP-002

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Toshihisa WATANABE et al.

U.S. Patent Application No. *not yet assigned*

Filed: *herewith*

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: Confirmation No.
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:

For: **X-RAY DETECTION DEVICE FOR FOREIGN MATTER**

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:


In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed with the application and no certification or fee is required.

Each non-English language reference was cited in the corresponding International search report or discussed in the present specification. A copy of the foreign search, together with an English language version thereof, is attached for the Examiner's information.

Respectfully submitted,

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INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)				ATTY. DOCKET NO. NIP-002		U.S. APPLICATION NO. Not yet assigned	
				APPLICANT Toshihisa WATANABE et al			
				FILING DATE herewith		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
	2002-131244	05/09/2002	JAPAN			abstract	
	03-057946	03/13/1991	JAPAN			abstract	
	2003-315286	11/06/2003	JAPAN			abstract	
	2004-125715	04/22/2004	JAPAN			abstract	
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER				DATE CONSIDERED			

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.